


FORM PTO 1449 (modified)				ATTY DOCKET NO. <b>01263.001800.</b>		APPLICATION NO. <b>09/718,342</b>	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				APPLICANT <b>ALEXANDER LYONS ET AL.</b>			
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				FILING DATE <b>November 24, 2000</b>		GROUP <b>2671</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AWC	5,625,782	04/29/97	Soutome et al.	395	341		
↓	5,745,098	04/28/98	Yamaji	345	121		
↓	5,945,996	08/31/99	Migdal et al.	345	420		
↓	6,081,273	06/27/00	Wend et al.	345	425		
↓	6,121,966	09/19/00	Teodosio et al.	345	346		
↓	6,184,859 B1	02/06/01	Kojima	345	130		
↓	6,516,099 B1	02/04/03	Davison et al.	382	284	08/05/98	
↓	6,647,146 B1	11/11/03	Davison et al.	382	199	08/05/98	
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
AWC	0 403 125 A2	12/19/90	EPO	G06F	3/033		
AWC	1 086 730 A2	03/28/01	EPO	A63F	13/10		
AWC	09-6984 A	01/10/97	JAPAN	—	—	Abstr.	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
AWC	Package: ZoomText Xtra - see <a href="http://members.tripod.com/magnifiers/ztxtra/html">http://members.tripod.com/magnifiers/ztxtra/html</a>						
↓	J. BLOOMENTHAL, "An Implicit Surface Polygonizer", Graphics Gems IV.8, AP Professional, 1994, pp. 324-350, ISBN 0-12-336155-9						
↓	C. WILES, ET AL., "Calibrating a Multi-Camera System for 3D Modelling," 1999 IEEE Workshop on Multi-View Modelling and Analysis of Visual Scenes, pp. 29-36, ISBN 0-7695-0110-9						
↓	R. M. HARALICK, ET AL., "The Facet Model," Computer and Robot Vision, Vol. 1, Ch. 8, Addison-Wesley (1992), pp. 371-452, ISBN 0-201-10877-1						
↓	R. M. HARALICK, ET AL., "2D to 3D Interface Using Perspective Projection," Computer and Robot Vision, Vol. 2, Ch. 13.4.15, Addison-Wesley (1993), pp. 85-91						
↓	W.E. LORENSEN, ET AL., "Marching Cubes: A High Resolution 3D Surface Construction Algorithm," Computer Graphics, SIGGRAPH 87 Proceedings, 21: 163-169 (July 1987)						
EXAMINER			DATE CONSIDERED				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. <b>1263.1800</b> APPLICANT <b>ALEXANDER LYONS ET AL.</b> FILING DATE <b>November 24, 2000</b>		APPLICATION NO. <b>09/718,342</b>  GROUP <b>2671</b>	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
						<b>RECEIVED</b>
						<b>JUL 12 2001</b>
						<b>Technology Center 2600</b>
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>Ans</i>	EP	0901105	03/10/99	EPO	G06T	7/00
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
<i>Ans</i>		"Calibration of Image Sequences For Model Visualisation", A. Broadhurst et al., 1999 IEEE Computer Society Conference On Computer Vision and Pattern Recognition, Vol. 1, pp. 100-105, June 23-25, 1999, Fort Collins, Colorado.				
<i> </i>		"Efficient Bundle Adjustment With Virtual Key Frames: A Hierarchical Approach To Multi-Frame Structure From Motion" Heung-Yeung Shum et al., 1999 IEEE Computer Society Conference On Computer Vision and Pattern Recognition, Vol. 2, pp. 538-543, June 23-25, 1999, Fort Collins, Colorado.				
<i> </i>		"A Robust Technique For Matching Two Uncalibrated Images Through The Recovery of The Unknown Epipolar Geometry", Zhengyou Zhang et al., Research Report No. 2273, INRIA Sophia-Antipolis, pp. 15-47, Cedesc (France), 1994.				
<i> </i>		"Photorealistic Scene Reconstruction by Voxel Coloring", S. Seitz et al., Proc. Conf. Computer Vision and Pattern Recognition, pp. 1067-1073, 1997.				
<i> </i>		"Plenoptic Image Editing", S. Seitz et al., Proc. 6 <sup>th</sup> International Conf. On Computer Vision, pp. 17-24.				
<i> </i>		"Rapid Octree Construction From Image Sequences", R. Szeliski, CVGIP: Image Understanding, Vol. 58, No. 1, pp. 23-48, July, 1993.				
<i> </i>		"Polynomial Expansion of Severely Aberrated Wave Fronts", J. Braat, J. Opt. Soc. Am. A, Vol. 4, No. 4, pp. 643-650, April, 1987.				
<i> </i>						
EXAMINER <i>[Signature]</i>		DATE CONSIDERED <i>6/24/04</i>				

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified)		ATTY DOCKET NO. 01263.001800.		APPLICATION NO. 09/718,342						
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT ALEXANDER LYONS ET AL.								
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE November 24, 2000		GROUP 2625						
U.S. PATENT DOCUMENTS										
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	FILING DATE IF APPROPRIATE					
AWC	5,819,016	10/06/98	Watanabe et al.	395	119					
RECEIVED MAR 09 2004 Technology Center 2600										
FOREIGN PATENT DOCUMENTS										
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	TRANSLATION YES/NO/ OR ABSTRACT					
AWC	WO 98/53428 A1	11/26/98	WIPO	G06T	17/40					
AWC	10-040421 A1	02/13/98	JAPAN	—	Abstract					
AWC	9-081778 A1	03/28/97	JAPAN	—	Abstract					
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
EXAMINER		DATE CONSIDERED								

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

APPLICANT

ALEXANDER LYONS ET AL.

FILING DATE

November 24, 2000

GROUP

2625

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AWL	Pub.	2001/0056308 A1	12/27/01	Petrov et al.	700	98	
AWL	Pub.	2002/0050988 A1	5/2/02	Petrov et al.	345	418	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

DATE CONSIDERED

6/24/04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1

NYMAIN400840

